Searcn Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination
10/531,492	HITOSHI ET AL.
Examiner	Art Unit
Sean E. Aeder	1642

SEARCHED					
Class	Subclass	Date	Examiner		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
STN (MEDLINE, BIOSIS, EMBASE, SCISEARCH, DISSABS; attached), MEDLINE, WEST (PGPB, USPT, USOC, EPAB, JPAB, DWPI; attached)	12/20/2007	SEA		
PALM inventor search	12/20/2007	SEA		
STIC seq id no:6	12/20/2007	SEA		
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